

Notice of References Cited	Application/Control No. 10/006,958	Applicant(s)/Patent Under Reexamination TAMADA ET AL.	
	Examiner TAN X. DINH	Art Unit 2653	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,660,452 b2	12-2003	Iwasaki et al.	430/270.13
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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